

**Search Notes**

Application/Control No.

10/605,255

Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
438	694	4/20/2005	BT
438	696	4/20/2005	BT
438	699	4/20/2005	BT
438	705	4/20/2005	BT
438	719	4/20/2005	BT
438	723	4/20/2005	BT
438	724	4/20/2005	BT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update search using EAST	4/20/2005	BT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
438	694	4/20/2005	BT
438	696	4/20/2005	BT
438	699	4/20/2005	BT
438/705 438/719 438/723 438/724		4/20/2005	BT